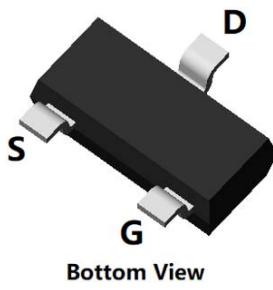
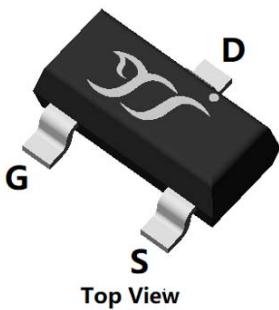
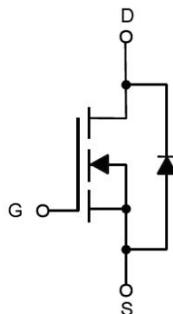


## N-Channel Enhancement Mode Field Effect Transistor

**SOT-23**

### Product Summary

- $V_{DS}$  60V
- $I_D$  3.0A
- $R_{DS(ON)}$  (at  $V_{GS}=10V$ ) <100mohm
- $R_{DS(ON)}$  (at  $V_{GS}=4.5V$ ) <120mohm

### General Description

- Trench Power MV MOSFET technology
- Excellent package for heat dissipation
- High density cell design for low  $R_{DS(ON)}$
- Moisture Sensitivity Level 1
- Epoxy Meets UL 94 V-0 Flammability Rating
- Halogen Free
- Part no. with suffix "Q" means AEC-Q101 qualified

### Applications

- DC-DC Converters
- Power management functions

### ■ Absolute Maximum Ratings ( $T_A=25^\circ C$ unless otherwise noted)

Parameter		Symbol	Limit	Unit
Drain-source Voltage		$V_{DS}$	60	V
Gate-source Voltage		$V_{GS}$	$\pm 20$	V
Drain Current	$T_A=25^\circ C$	$I_D$	3	A
	$T_A=70^\circ C$		2.4	
Pulsed Drain Current <sup>A</sup>		$I_{DM}$	12	A
Total Power Dissipation	$T_A=25^\circ C$	$P_D$	1.2	W
	$T_A=70^\circ C$		0.8	
Thermal Resistance Junction-to-Ambient <sup>B</sup>		$R_{\theta JA}$	104	$^\circ C/W$
Junction and Storage Temperature Range		$T_J, T_{STG}$	-55~+150	$^\circ C$

### ■ Ordering Information (Example)

PREFERRED P/N	PACKING CODE	Marking	MINIMUM PACKAGE(pcs)	INNER BOX QUANTITY(pcs)	OUTER CARTON QUANTITY(pcs)	DELIVERY MODE
YJL03N06AQ	F2	S10.	3000	30000	120000	7" reel



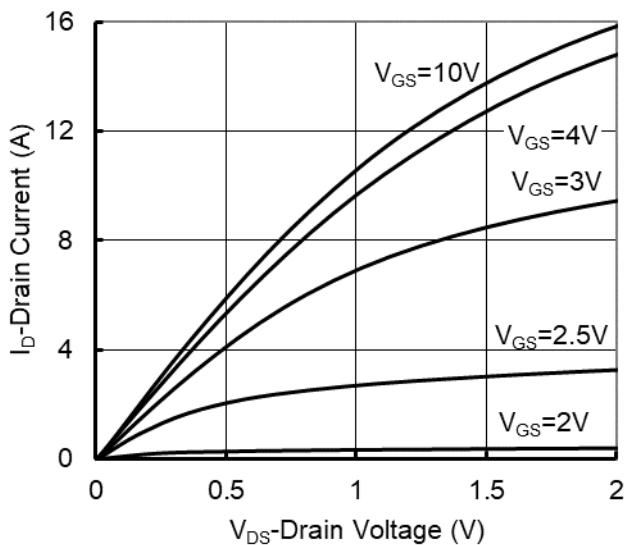
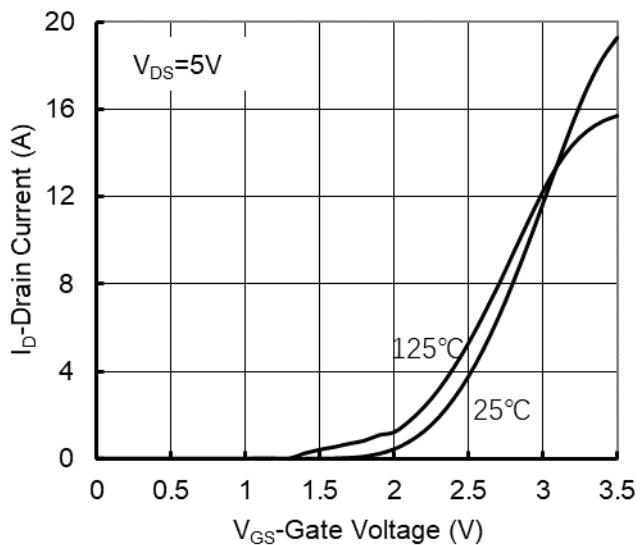
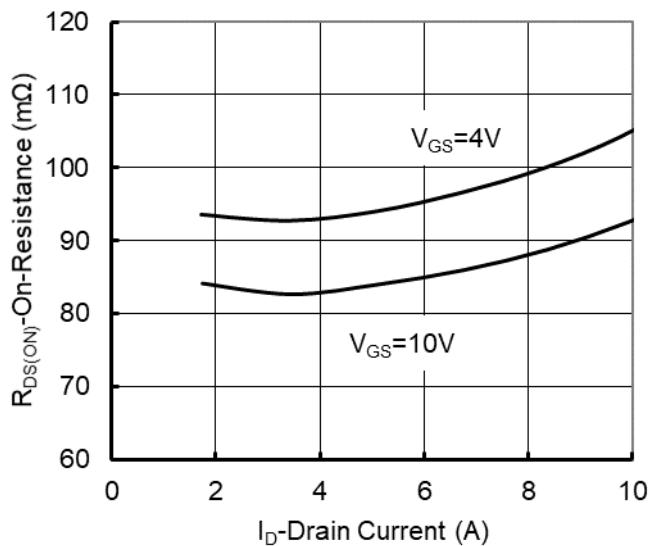
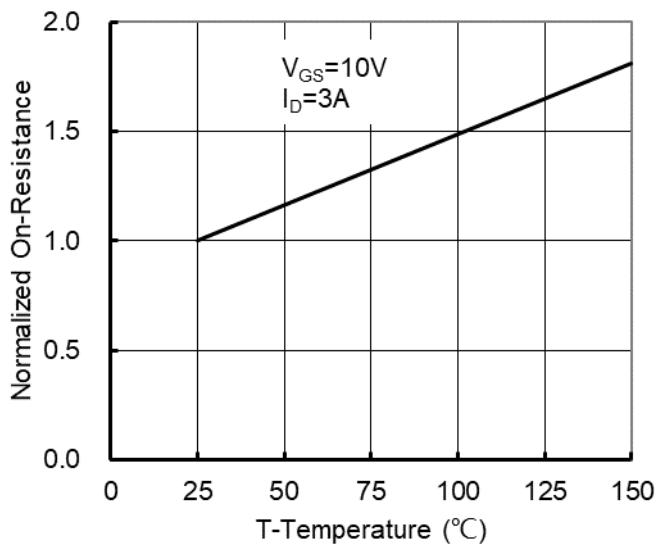
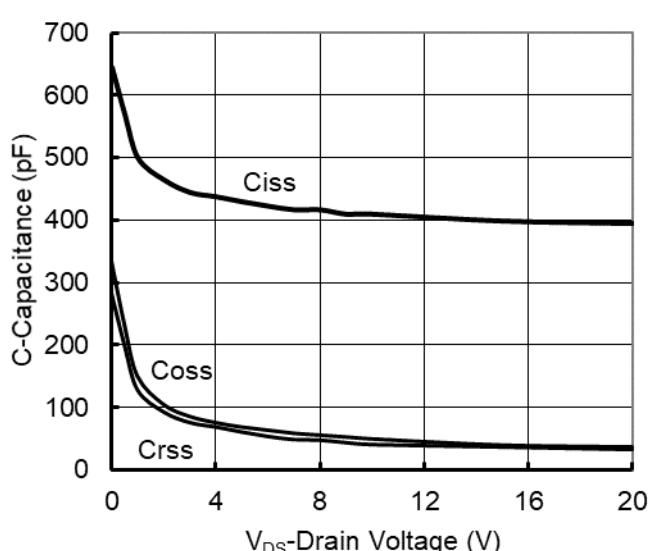
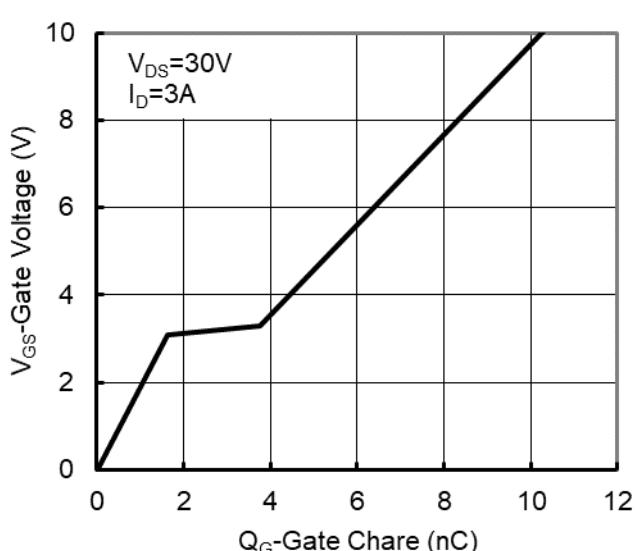
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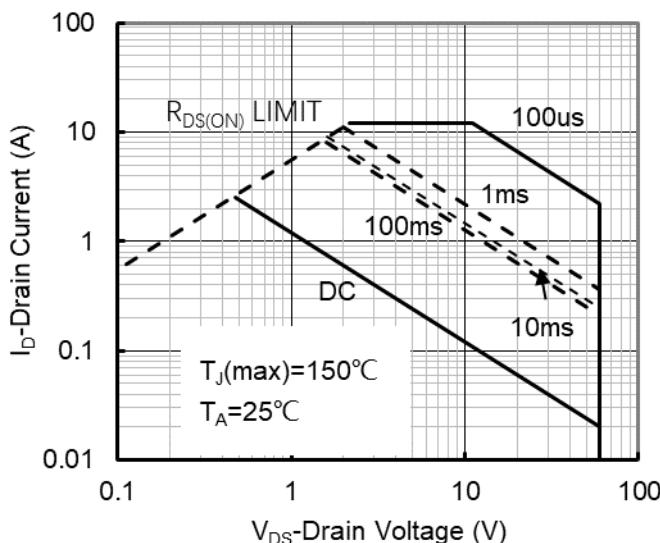
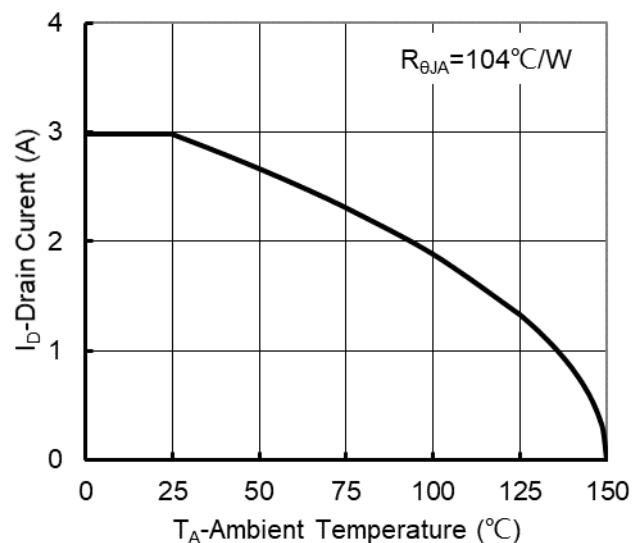
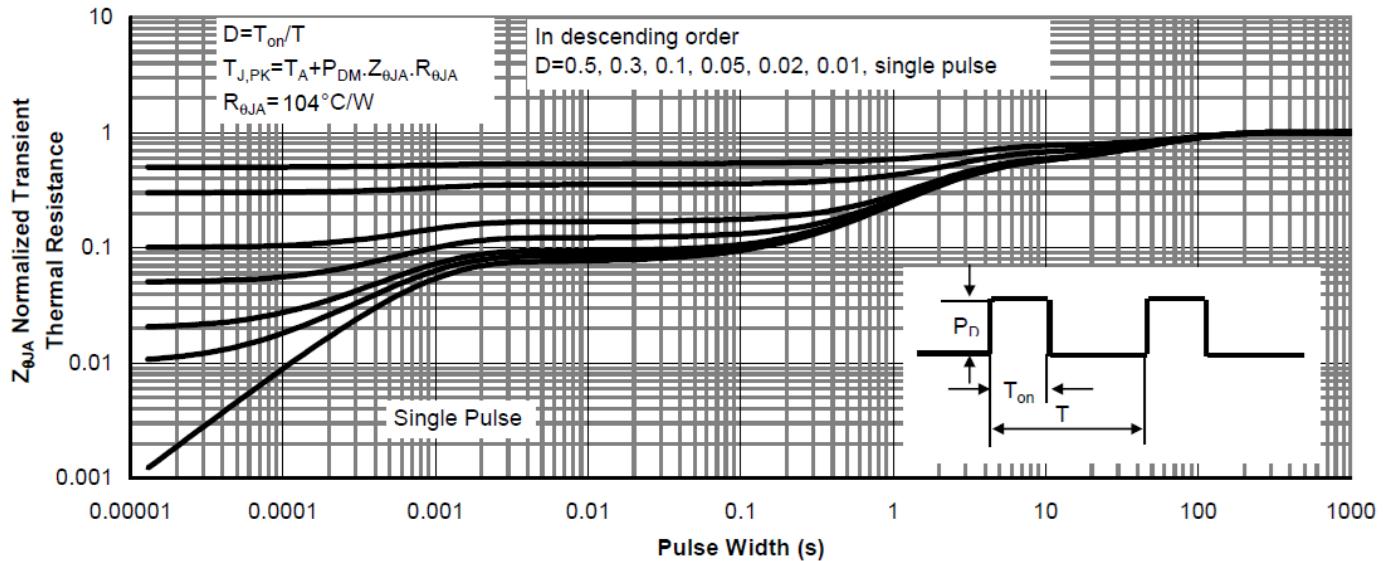
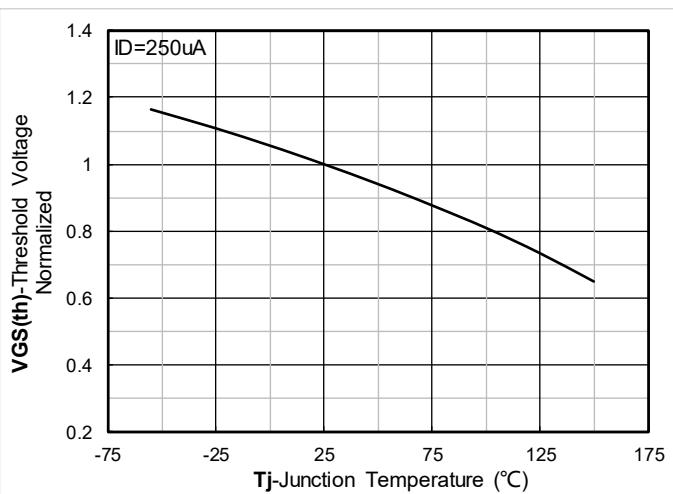
**■ Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

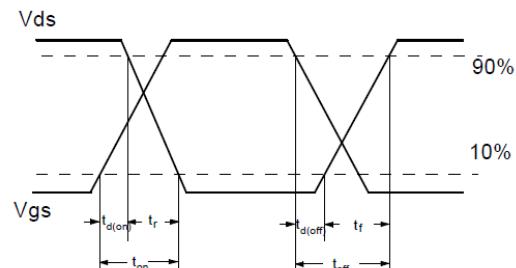
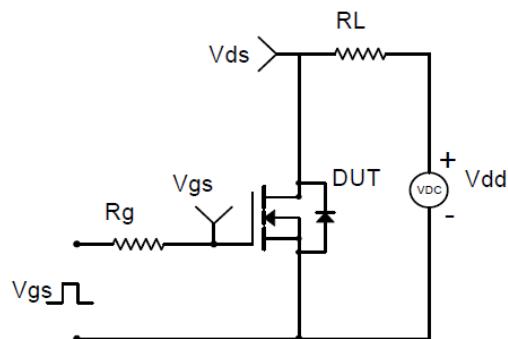
Parameter	Symbol	Conditions	Min	Typ	Max	Units
<b>Static Parameter</b>						
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	60			V
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{\text{DS}}=60\text{V}, V_{\text{GS}}=0\text{V}$			1	$\mu\text{A}$
Gate-Body Leakage Current	$I_{\text{GSS}1}$	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$			$\pm 100$	nA
	$I_{\text{GSS}2}$	$V_{\text{GS}}=\pm 10\text{V}, V_{\text{DS}}=0\text{V}$			$\pm 50$	
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	0.9	1.3	2.0	V
Static Drain-Source On-Resistance	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=3\text{A}$		86	100	mΩ
		$V_{\text{GS}}=4.5\text{V}, I_{\text{D}}=2\text{A}$		92	120	
Diode Forward Voltage	$V_{\text{SD}}$	$I_{\text{S}}=3\text{A}, V_{\text{GS}}=0\text{V}$			1.2	V
<b>Dynamic Parameters</b>						
Input Capacitance	$C_{\text{iss}}$	$V_{\text{DS}}=10\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$		409		pF
Output Capacitance	$C_{\text{oss}}$			50		
Reverse Transfer Capacitance	$C_{\text{rss}}$			41		
<b>Switching Parameters</b>						
Total Gate Charge	$Q_g$	$V_{\text{GS}}=10\text{V}, V_{\text{DS}}=30\text{V}, I_{\text{D}}=3\text{A}$		10.27		nC
Gate-Source Charge	$Q_{\text{gs}}$			1.65		
Gate-Drain Charge	$Q_{\text{gd}}$			2.11		
Reverse Recovery Charge	$Q_{\text{rr}}$	$I_{\text{F}}=3\text{A}, \frac{dI}{dt}=100\text{A/us}$		6.99		ns
Reverse Recovery Time	$t_{\text{rr}}$			32.6		
Turn-on Delay Time	$t_{\text{D(on)}}$	$V_{\text{GS}}=10\text{V}, V_{\text{DS}}=30\text{V}, R_{\text{L}}=20\Omega, R_{\text{GEN}}=3\Omega$		3.6		ns
Turn-on Rise Time	$t_r$			17.6		
Turn-off Delay Time	$t_{\text{D(off)}}$			13		
Turn-off fall Time	$t_f$			23		

A. Pulse Test: Pulse Width  $\leq 300\text{us}$ , Duty cycle  $\leq 2\%$ .

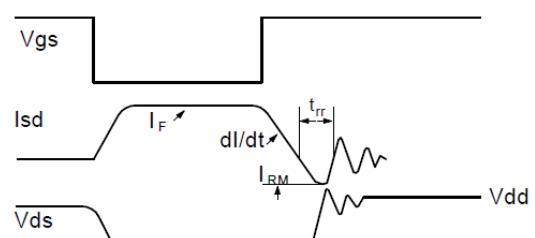
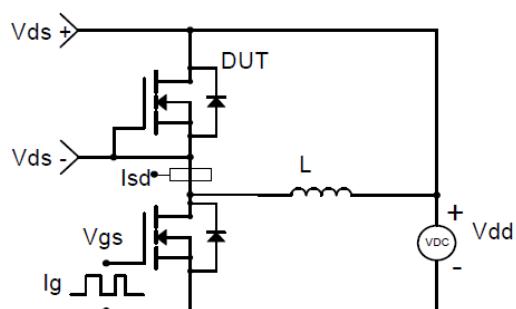
B.  $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance, where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design, while  $R_{\theta JA}$  is determined by the board design. The maximum rating presented here is based on mounting on a 1 in 2 pad of 2oz copper.

**■ Typical Performance Characteristics****Figure 1. Output Characteristics****Figure 2. Transfer Characteristics****Figure 3: On-Resistance vs. Drain Current and Gate Voltage****Figure 4: On-Resistance vs. Junction Temperature****Figure 5. Capacitance Characteristics****Figure 6. Gate Charge**

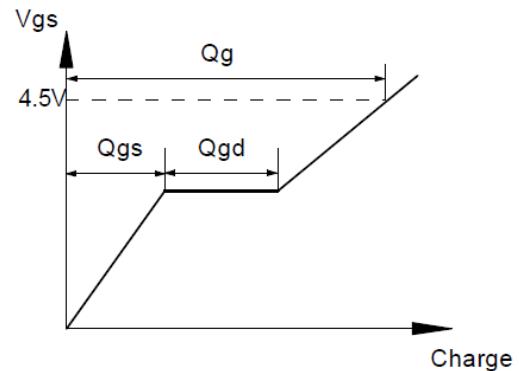
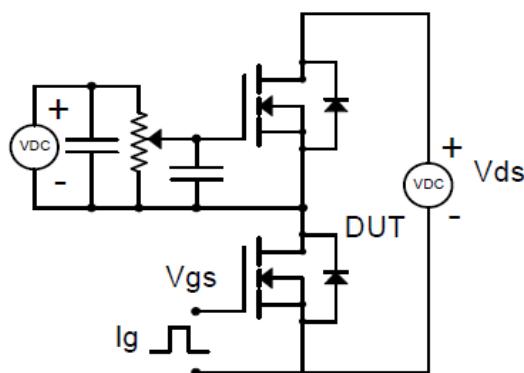

**Figure 7. Safe Operation Area**

**Figure 8. Maximum Continuous Drain Current vs Ambient Temperature**

**Figure 9. Normalized Maximum Transient Thermal Impedance**

**Figure 10. Normalized Threshold voltage**



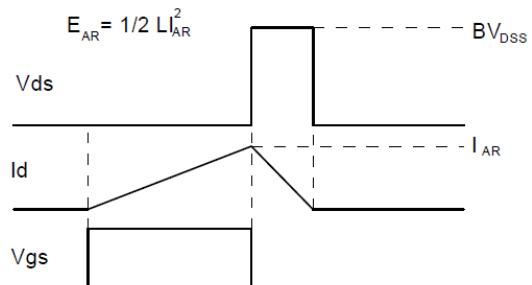
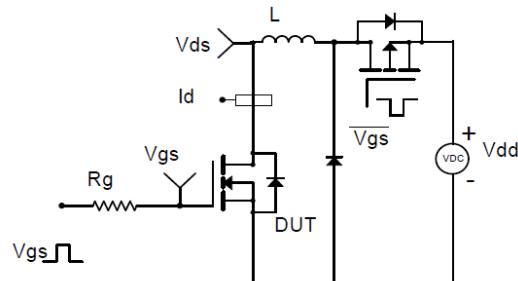
**Resistive Switching Test Circuit & Waveforms**



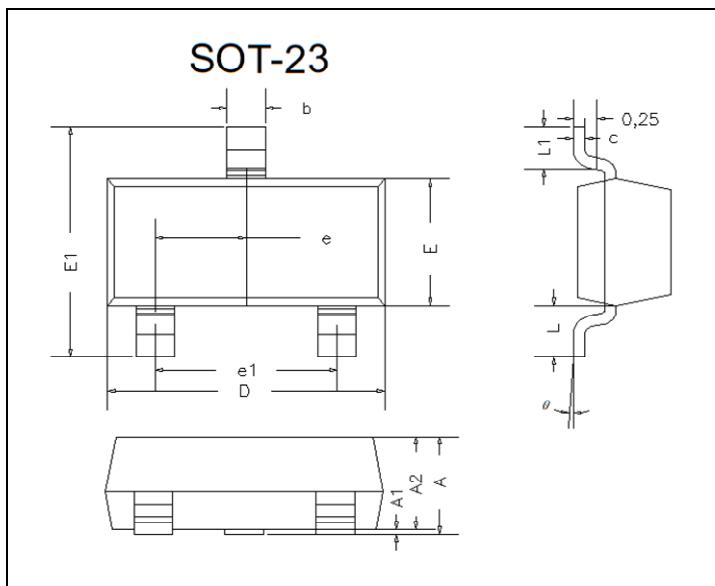
**Diode Recovery Test Circuit & Waveforms**



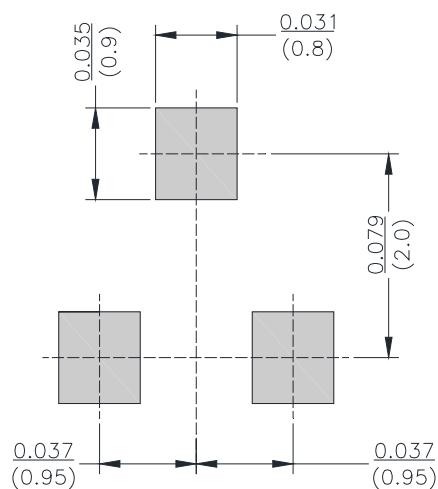
**Gate Charge Test Circuit & Waveform**



**Unclamped Inductive Switching (UIS) Test Circuit & Waveforms**

**■ SOT-23 Package information**

DIM	INCHES		MM		NOTE
	MIN	MAX	MIN	MAX	
A	0.035	0.045	0.90	1.15	
A1	0.000	0.004	0.00	0.10	
A2	0.035	0.041	0.90	1.05	
b	0.012	0.020	0.30	0.50	
c	0.004	0.008	0.10	0.20	
D	0.110	0.118	2.80	3.00	
E	0.047	0.055	1.20	1.40	
E1	0.089	0.100	2.25	2.55	
e	0.370TYP		0.95TYP		
e1	0.071	0.079	1.80	2.00	
L	0.220REF		0.55REF		
L1	0.012	0.020	0.30	0.50	
θ	0°	8°	0°	8°	

**■ SOT-23 Suggested Pad Layout**



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